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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/809,867	03/26/2004	Masanori Ucda	025720-00027	7607
ARENT FOX I	7590 12/27/200 KINTNER PLOTKIN &	EXAMINER		
Suite 400		TUGBANG, ANTHONY D		
1050 Connecticut Avenue, N.W. Washington, DC 20036-5339			ART UNIT	PAPER NUMBER
3 .		3729		
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SHORTENED STATUTOR	Y PERIOD OF RESPONSE	MAIL DATE	DELIVERY MODE	
3 MONTHS 12/27/2006		PAPER		

Please find below and/or attached an Office communication concerning this application or proceeding.

If NO period for reply is specified above, the maximum statutory period will apply and will expire 6 MONTHS from the mailing date of this communication.

		Application No.	Applicant(s)			
Office Action Summary		10/809,867	UEDA ET AL.			
		Examiner	Art Unit			
		A. Dexter Tugbang	3729			
Dorind fo	The MAILING DATE of this communication ap	pears on the cover sheet with t	the correspondence address			
Period fo			T. ((0) OD T. ((00) DA)(0			
WHIC - Exte after - If NC - Failu Any	ORTENED STATUTORY PERIOD FOR REPL CHEVER IS LONGER, FROM THE MAILING Designs of time may be available under the provisions of 37 CFR 1. SIX (6) MONTHS from the mailing date of this communication. Depriod for reply is specified above, the maximum statutory period tree to reply within the set or extended period for reply will, by statute reply received by the Office later than three months after the mailing ed patent term adjustment. See 37 CFR 1.704(b).	DATE OF THIS COMMUNICA- 136(a). In no event, however, may a reply will apply and will expire SIX (6) MONTHS e, cause the application to become ABAND	TION. be timely filed from the mailing date of this communication. DONED (35 U.S.C. § 133).			
Status						
1)[🛛	Responsive to communication(s) filed on 10 C	October 2006.				
•		s action is non-final.				
3)□	·					
closed in accordance with the practice under Ex parte Quayle, 1935 C.D. 11, 453 O.G. 213.						
Disposit	ion of Claims					
4)⊠	4)⊠ Claim(s) <u>1-17</u> is/are pending in the application.					
• / 🕰	4a) Of the above claim(s) <u>5-10 and 14-17</u> is/are withdrawn from consideration.					
5)□	Claim(s) is/are allowed.					
6)⊠						
7)	.Claim(s) is/are objected to.					
8)[8) Claim(s) are subject to restriction and/or election requirement.					
Applicat	ion Papers					
9)□	The specification is objected to by the Examine	er.	•			
10) The drawing(s) filed on is/are: a) accepted or b) objected to by the Examiner.						
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).						
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).						
11)	The oath or declaration is objected to by the E	xaminer. Note the attached O	ffice Action or form PTO-152.			
Priority (under 35 U.S.C. § 119	•				
12)⊠ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).						
a)⊠ All b)☐ Some * c)☐ None of:						
1. Certified copies of the priority documents have been received.						
2. Certified copies of the priority documents have been received in Application No						
3. Copies of the certified copies of the priority documents have been received in this National Stage						
	application from the International Burea					
* See the attached detailed Office action for a list of the certified copies not received.						
Attachment(s)						
	e of References Cited (PTO-892)		mary (PTO-413)			
	ce of Draftsperson's Patent Drawing Review (PTO-948) mation Disclosure Statement(s) (PTO/SB/08)		ail Date nal Patent Application			
	r No(s)/Mail Date	6) Other:				

DETAILED ACTION

Response to Amendment

- 1. The applicant(s) amendment and response filed on October 10, 2006 has been fully considered and made of record.
- 2. The text of those sections of Title 35, U.S. Code not included in this action can be found in a prior Office action.

Election/Restrictions

3. Claims 5 through 10 and 14 through 17 continue to stand as being withdrawn from further consideration pursuant to 37 CFR 1.142(b) as being drawn to a nonelected invention, there being no allowable generic or linking claim. Election was made **without** traverse in the reply filed on March 13, 2006.

Claim Rejections - 35 USC § 103

4. Claims 1, 2, 3, 11 and 13 are rejected under 35 U.S.C. 103(a) as being unpatentable over the combination of Onishi et al 6,426,583, Beyne et al 5,731,584, and Kawaura et al 4,426,595.

Regarding Claim(s) 1, Onishi discloses a method of fabricating a surface acoustic wave device (Figures 9A through 9E, col. 6, lines 54+) comprising: joining a supporting substrate (e.g. 102a in Fig. 9A) to a second surface (bottom surface) of a piezoelectric substrate 101a opposite to a first surface (top surface of 101a); grinding and polishing the first surface (top surface of 101a) of the piezoelectric substrate; forming, on the first surface of the piezoelectric substrate, on on-chip pattern including comb-shaped electrodes (e.g. 104); and grinding a third

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surface (bottom surface of 102a) of the supporting substrate opposite another surface (top surface of 102a) of the supporting substrate to which the second surface (bottom surface of 101a) of the piezoelectric substrate is joined.

Regarding Claim(s) 2, Onishi further teaches forming the on-chip pattern two-dimensionally and cutting a joined substrate having the grinded and polished supporting substrate and the piezoelectric substrate into parts each of which parts has a respective one of the on-chip patterns arranged two-dimensionally (see cutting sequence of Figs. 9D to 9E). Note that the claimed "joined substrate" is read as the joining of supporting substrate 102a and piezoelectric substrate 101a (in Fig. 9B) after each has been grinded or thinned, and subsequently, this joined substrate (e.g. 101a, 102a in Fig. 9B) is cut (as shown in Fig. 9E).

Regarding Claim(s) 3, Onishi further teaches housing each of the parts into a respective cavity formed in a first substrate (e.g. 301 and cross-hatched layers not labeled above 301 in Fig. 11), and sealing the respective cavity with a second substrate (e.g. 305).

Regarding Claim(s) 11 and 13, Onishi further suggests that the supporting substrate can be made of silicon such that it is a silicon substrate (col. 4, lines 47-50) and that the piezoelectric substrate contains a major component of lithium niobate (col. 4, lines 33-37).

Onishi teaches substantially all of the limitations of the claimed manufacturing method except that the step of grinding the third surface of the supporting substrate includes polishing of the third surface (as required by Claim 1). Furthermore, Onishi does not mention that electrode pads are formed on the first surface of the piezoelectric substrate (also required by Claim 1).

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Beyne suggests that a surface of a supporting substrate (e.g. 11), made of the very same material of silicon, can be flattened and thinned by conventional steps of both grinding and polishing (col. 4, lines 17-28).

It would have been obvious to one of ordinary skill in the art at the time the invention was made to have modified the method of Onishi by adding the polishing step, along with grinding, on the third surface of the supporting substrate, as taught by Beyne, to positively flatten and thin the supporting substrate to achieve a certain thickness or dimension.

Kawaura teaches that electrode pads (e.g. P₁, P₂, P₃ or P₄) can be formed with combshaped electrodes to provide an electrical connection and signal to the on-chip pattern of electrode pads and comb shaped electrodes on the surface acoustic wave device (col. 3, lines 20-27).

It would have been obvious to one of ordinary skill in the art at the time the invention was made to have modified the method of Onishi by adding the electrode pads to the on-chip pattern, as taught by Kawaura, to positively provide an electrical connection and signal to the surface acoustic wave device and allow the device to operate.

5. Claim 4 is rejected under 35 U.S.C. 103(a) as being unpatentable over Onishi et al, Kawaura et al, and Beyne et al, as applied to Claims 1, 2 and 3 above, and further in view of European Patent 0 557 756, referred to hereinafter as EP'756.

Onishi, as modified by Kawaura and Beyne, discloses the claimed manufacture method as relied upon above. The modified Onishi method does not teach subjecting one of the joining surfaces of the first and second substrates to a surface activation process that uses plasma and oxygen.

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It is noted that sealing of the first and second substrates of Onishi is accomplished by soldering.

EP'756 teaches that substrates, prior to being joined (by soldering), can be cleaned in a preliminary step with a surface activation process of plasma and oxygen (Abstract).

It would have been obvious to one of ordinary skill in the art at the time the invention was made to have modified Onishi by including a surface treatment process of plasma and oxygen on the surface of either the first or second substrate, as taught by EP'756, to provide a clean surface for joining of the first and second substrates (by soldering).

6. Claim 12 is rejected under 35 U.S.C. 103(a) as being unpatentable over Onishi et al, Kawaura et al, and Beyne et al, as applied to claim 1 above, and further in view of Romanofsky 6,292,143.

Onishi, as modified by Kawaura and Beyne, discloses the claimed manufacture method as relied upon above, further including that the supporting substrate can be made of silicon. The modified Onishi method does not teach that the resistivity of the supporting substrate with silicon is $100\,\Omega$ - m.

Romanofsky teaches that forming a substrate using high resistivity silicon provides the substrate with a resistivity of 1000Ω - cm (equal to 100Ω - m) and is advantageous because of the semiconductor properties (col. 8, lines 50+).

It would have been obvious to one of ordinary skill in the art at the time the invention was made to have modified the supporting substrate of Onishi by forming the supporting substrate with high resistivity silicon, as taught by Romanofsky, to advantageously provide the

supporting substrate with a resistivity of 1000 Ω - cm (equal to 100 Ω - m) and semiconductor properties.

Response to Arguments

7. The applicant(s) arguments filed on October 10, 2006 have been fully considered but they are not persuasive.

The applicant(s) assert that the prior art does not teach all of the limitations of Claim 1, particularly noting step (d) of grinding and polishing a third surface of the supporting substrate, as amended. In the response filed on October 10, 2006, Claim 1 was amended to recite that the step of grinding and polishing of the third surface of the supporting substrate now occurs in step (d), as amended, rather than as step (c), as previously recited.

The examiner's position is that the above rejection can be maintained because simply reciting the step of grinding and polishing of the third surface as step (d) does not change the order of the steps as now recited. The step of "(d) grinding...is joined" (lines 11-13 of Claim 1) does not recite any relationship relative to steps (b) and (c) where the *only* order that step (d) must occur in is after step (a). The recitation of "the supporting substrate to which the second surface" (line 12) in step (d) provides an order where step (d) must occur after (a) by antecedent basis of the terms of "supporting substrate" and "second surface". But nowhere else does step (d) provide any relationship relative to steps (b) and (c). Thus, the order of steps of the prior art as noted above still reads on the claims.

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Conclusion

8. THIS ACTION IS MADE FINAL. Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the mailing date of this final action.

9. Any inquiry concerning this communication or earlier communications from the examiner should be directed to A. Dexter Tugbang whose telephone number is 571-272-4570. The examiner can normally be reached on Monday - Friday 7:30 am - 4:00 pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Peter Vo can be reached on 571-272-4690. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

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A. Dexter Tugbang
Primary Examiner

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December 18, 2006